

**HIGH NOISE REDUCTION/HIGH-SPEED 10 Mbps, TOTEM-POLE OUTPUT TYPE  
5-PIN SOP TOM PHOTOCOUPLER**      -NEPOC™ Series-**DESCRIPTION**

The PS9711 is an optically coupled high-speed, totem-pole output isolator containing a GaAlAs LED on light emitting diode (input) and a photodiode and a signal processing circuit on light receiving side (output side) on one chip.

**FEATURES**

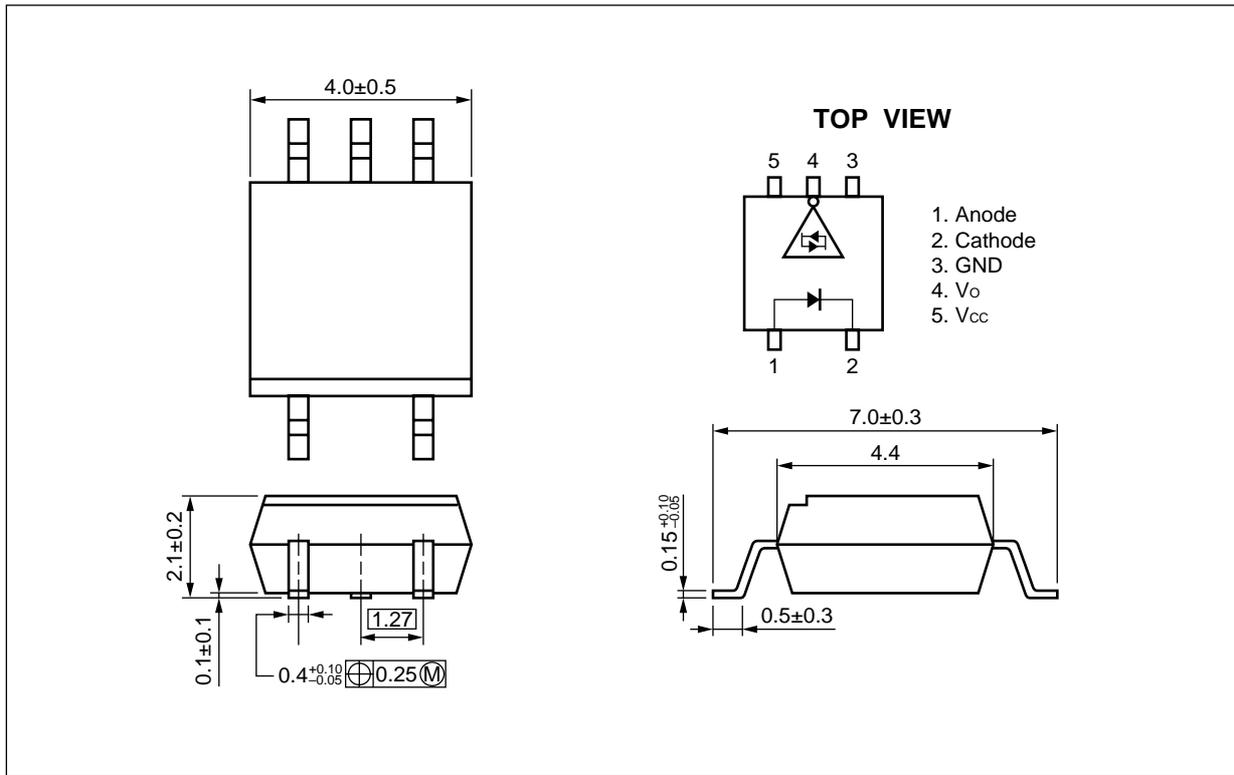
- High common mode transient immunity ( $CM_H, CML = \pm 10 \text{ kV}/\mu\text{s}$  TYP.)
- Small package (5-pin SOP)
- ★ High-speed response ( $t_{PHL} = 30 \text{ ns}, t_{PLH} = 35 \text{ ns}$  TYP.)
- Pulse width distortion ( $|t_{PHL} - t_{PLH}| = 7 \text{ ns}$  TYP.)
- Totem-pole output (No pull-up resistor required)
- Ordering number of taping product: PS9711-E3, E4: 900 pcs/reel,  
PS9711-F3, F4 (Recommended): 3 500 pcs/reel

**APPLICATIONS**

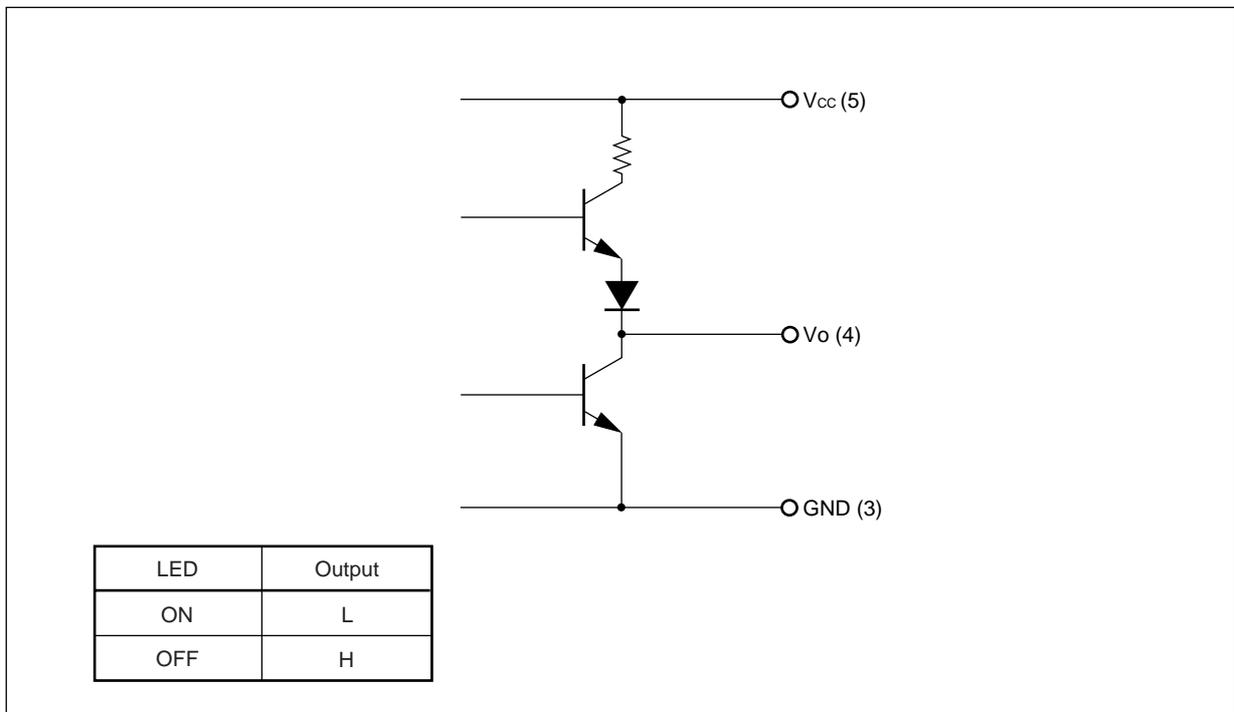
- Computer and peripheral manufactures
- Measurement equipment
- PDP

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Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

PACKAGE DIMENSIONS (in millimeters)



★ INTERNAL OUT PUT CIRCUIT



**ORDERING INFORMATION**

Part Number	Package	Packing Style	Application Part Number <sup>*1</sup>
PS9711	5-pin SOP	Magazine case 100 pcs	PS9711
PS9711-E3		Embossed Tape 900 pcs/reel	
PS9711-E4			
PS9711-F3		Embossed Tape 3 500 pcs/reel	
PS9711-F4			

\*1 For the application of the Safety Standard, following part number should be used.

**ABSOLUTE MAXIMUM RATINGS (T<sub>A</sub> = 25 °C, unless otherwise specified)**

Parameter		Symbol	Ratings	Unit
Diode	Forward Current	I <sub>F</sub>	30	mA
	Reverse Voltage	V <sub>R</sub>	3.0	V
Detector	Supply Voltage	V <sub>CC</sub>	7	V
	Output Voltage	V <sub>O</sub>	7	V
	High Level Output Current <sup>*1</sup>	I <sub>OH</sub>	-5	mA
	Low Level Output Current <sup>*1</sup>	I <sub>OL</sub>	13	mA
	Power Dissipation <sup>*1</sup>	P <sub>C</sub>	130	mW
Isolation Voltage <sup>*2</sup>		BV	2 500	Vr.m.s.
Operating Ambient Temperature		T <sub>A</sub>	-40 to +85	°C
Storage Temperature		T <sub>stg</sub>	-55 to +125	°C

\*1 T<sub>A</sub> = -40 to +85 °C

\*2 AC voltage for 1 minute at T<sub>A</sub> = 25 °C, RH = 60 % between input and output.

**RECOMMENDED OPERATING CONDITIONS**

Parameter	Symbol	MIN.	TYP.	MAX.	Unit
★ High Level Input Current	I <sub>FH</sub>	7.5		12.5	mA
Low Level Input Current	I <sub>FL</sub>	0		250	μA
Supply Voltage	V <sub>CC</sub>	4.5	5.0	5.5	V
TTL (loads)	N			3	

**ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = -40 to +85 °C, unless otherwise specified)**

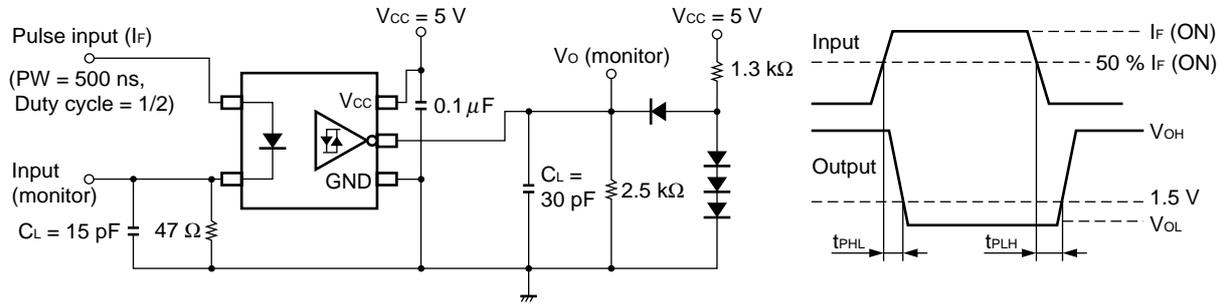
Parameter		Symbol	Conditions	MIN.	TYP. <sup>1</sup>	MAX.	Unit	
Diode	Forward Voltage	V <sub>F</sub>	I <sub>F</sub> = 10 mA, T <sub>A</sub> = 25 °C	1.4	1.65	1.9	V	
	Reverse Current	I <sub>R</sub>	V <sub>R</sub> = 3 V, T <sub>A</sub> = 25 °C			10	μA	
	Terminal Capacitance	C <sub>t</sub>	V = 0 V, f = 1 MHz, T <sub>A</sub> = 25 °C		30		pF	
Detector	High Level Output Current	I <sub>OH</sub>	V <sub>CC</sub> = V <sub>O</sub> = 5.5 V, I <sub>F</sub> = 250 μA		1	200	μA	
	High Level Output Voltage	V <sub>OH</sub>	V <sub>CC</sub> = 4.5 V, I <sub>F</sub> = 250 μA, I <sub>OH</sub> = -2 mA	2.4	3.0		V	
	Low Level Output Voltage	V <sub>OL</sub>	V <sub>CC</sub> = 4.5 V, I <sub>F</sub> = 7 mA, I <sub>O</sub> = 8 mA		0.38	0.6	V	
	High Level Supply Current	I <sub>CCH</sub>	V <sub>CC</sub> = 5.5 V, I <sub>F</sub> = 0 mA		11	17	mA	
	Low Level Supply Current	I <sub>CCL</sub>	V <sub>CC</sub> = 5.5 V, I <sub>F</sub> = 10 mA		12	18	mA	
	High Level Output Short Circuit Current	I <sub>OSH</sub>	V <sub>CC</sub> = 5.5 V, V <sub>O</sub> = GND, I <sub>F</sub> = 0 mA, 10 ms or less		-26		mA	
	Low Level Output Short Circuit Current	I <sub>OSL</sub>	V <sub>CC</sub> = V <sub>O</sub> = 5.5 V, I <sub>F</sub> = 8 mA, 10 ms or less		34		mA	
Coupled	Threshold Input Current (H → L)	I <sub>FHL</sub>	V <sub>CC</sub> = 5 V	T <sub>A</sub> = 25 °C		2.0	5	mA
							6	
	Threshold Input Current (L → H)	I <sub>FLH</sub>	V <sub>CC</sub> = 5 V	T <sub>A</sub> = 25 °C	0.5			mA
					0.35			
	Isolation Resistance	R <sub>I-O</sub>	V <sub>I-O</sub> = 1 kV <sub>DC</sub> , R <sub>H</sub> = 40 to 60 %, T <sub>A</sub> = 25 °C	10 <sup>11</sup>				Ω
	Isolation Capacitance	C <sub>I-O</sub>	V = 0 V, f = 1 MHz, T <sub>A</sub> = 25 °C		0.4		pF	
	Propagation Delay Time (H → L) <sup>2</sup>	t <sub>PHL</sub>	V <sub>CC</sub> = 5 V, I <sub>F</sub> = 7.5 mA	T <sub>A</sub> = 25 °C	15	30	65	ns
					10		85	
	Propagation Delay Time (L → H) <sup>2</sup>	t <sub>PLH</sub>	V <sub>CC</sub> = 5 V, I <sub>F</sub> = 7.5 mA	T <sub>A</sub> = 25 °C	15	35	65	ns
					10		85	
Pulse Width Distortion (PWD) <sup>2</sup>	t <sub>PHL</sub> -t <sub>PLH</sub>	V <sub>CC</sub> = 5 V, I <sub>F</sub> = 7.5 mA		7	35		ns	
Common Mode Transient Immunity at High Level Output <sup>3</sup>	CM <sub>H</sub>	V <sub>CC</sub> = 5 V, T <sub>A</sub> = 25 °C, I <sub>F</sub> = 0 mA, V <sub>O(MIN.)</sub> = 2 V, V <sub>CM</sub> = 100 V		1	10		kV/μs	
Common Mode Transient Immunity at Low Level Output <sup>3</sup>	CM <sub>L</sub>	V <sub>CC</sub> = 5 V, T <sub>A</sub> = 25 °C, I <sub>F</sub> = 7.5 mA, V <sub>O(MAX.)</sub> = 0.8 V, V <sub>CM</sub> = 100 V		1	10		kV/μs	

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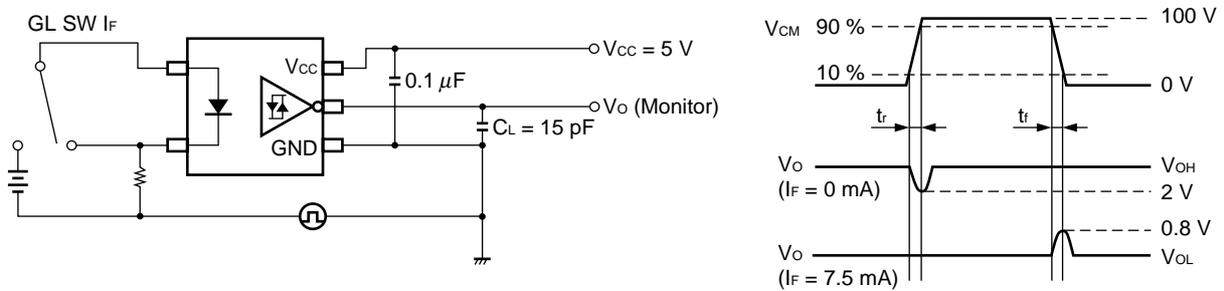
\*1 Typical values at  $T_A = 25\text{ }^\circ\text{C}$

\*2 Test circuit for propagation delay time



$C_L$  is approximately which includes probe and stray wiring capacitance.

\*3 Test circuit for common mode transient immunity

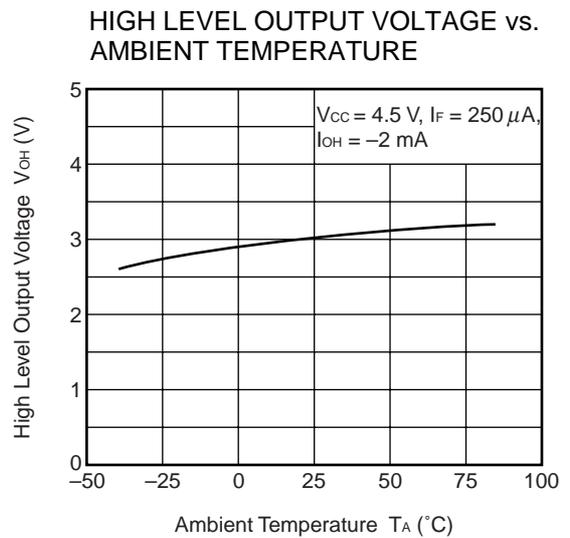
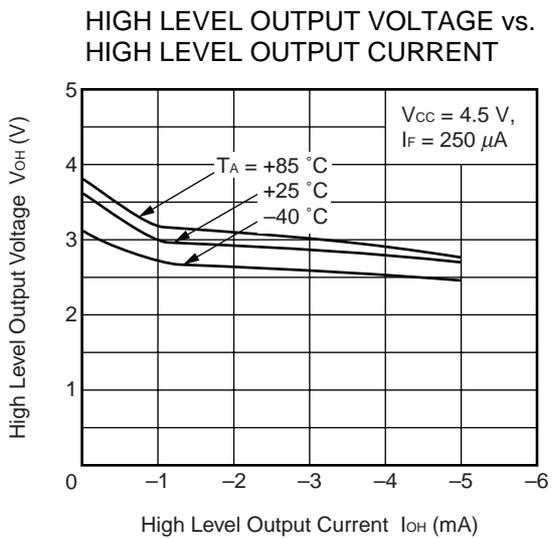
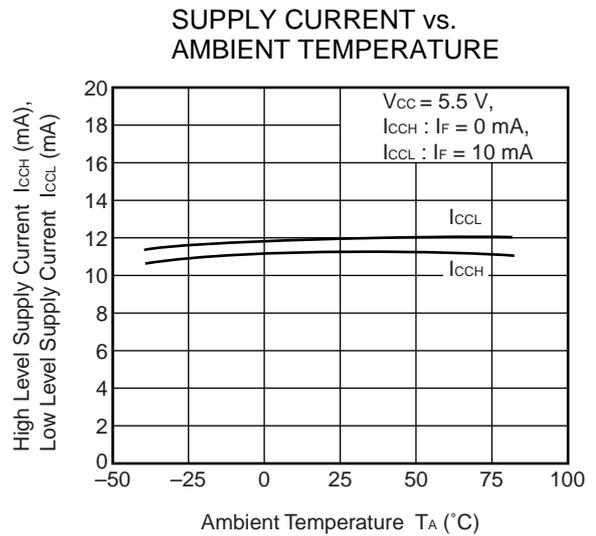
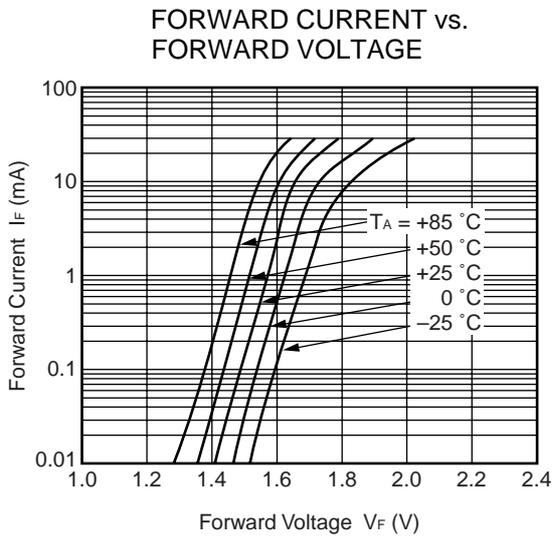
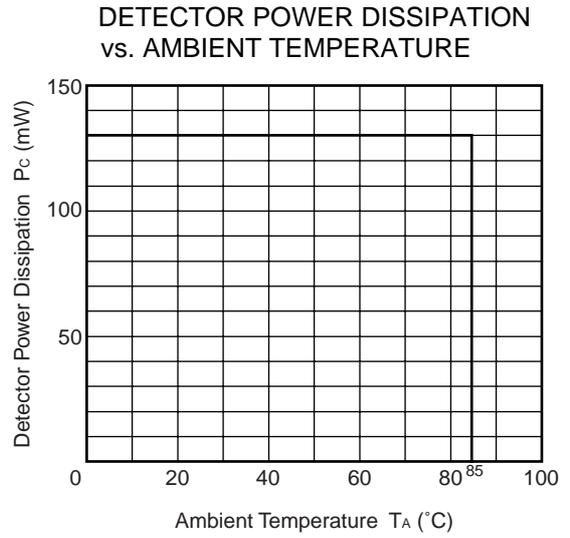
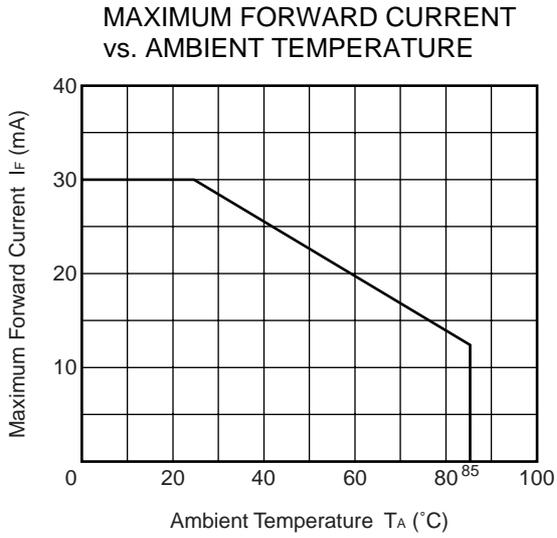


$C_L$  is approximately which includes probe and stray wiring capacitance.

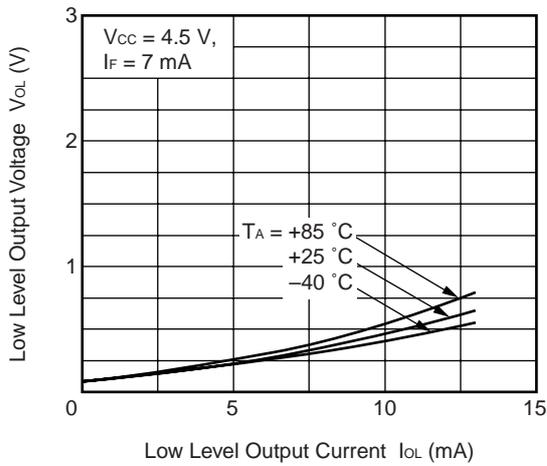
**USAGE CAUTIONS**

1. This product is weak for static electricity by designed with high-speed integrated circuit so protect against static electricity when handling.
2. By-pass capacitor of more than  $0.1\text{ }\mu\text{F}$  is used between  $V_{CC}$  and GND near device.

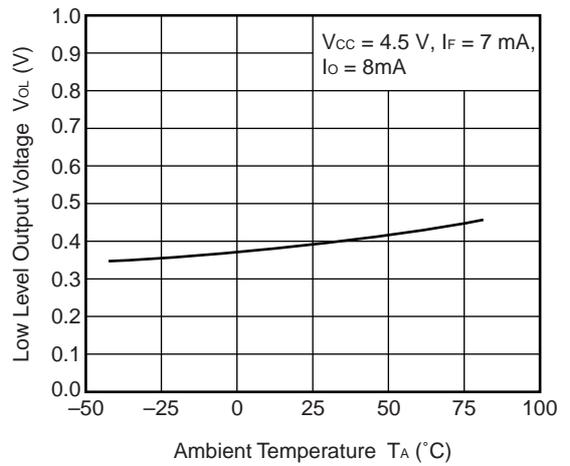
TYPICAL CHARACTERISTICS (T<sub>A</sub> = 25 °C, unless otherwise specified)



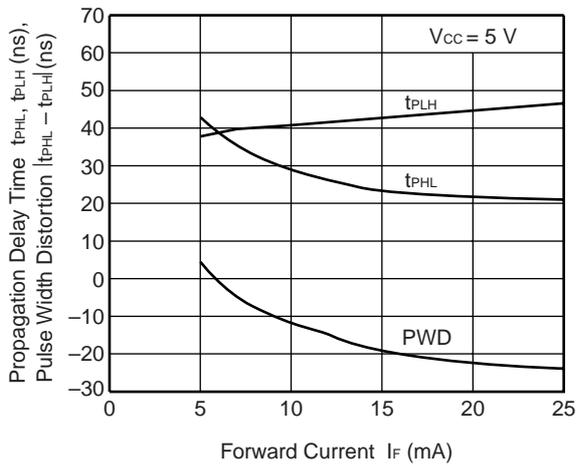
LOW LEVEL OUTPUT VOLTAGE vs. LOW LEVEL OUTPUT CURRENT



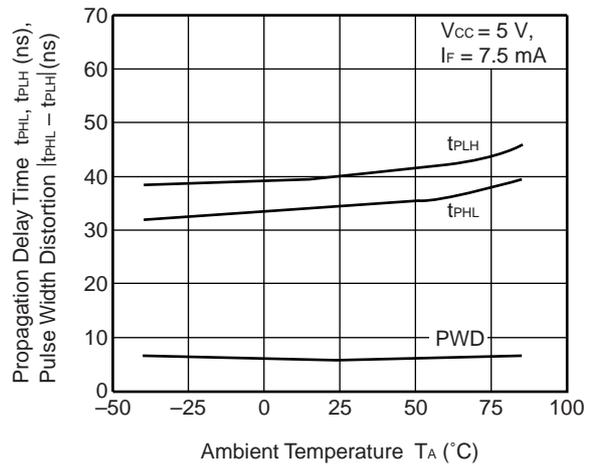
LOW LEVEL OUTPUT VOLTAGE vs. AMBIENT TEMPERATURE



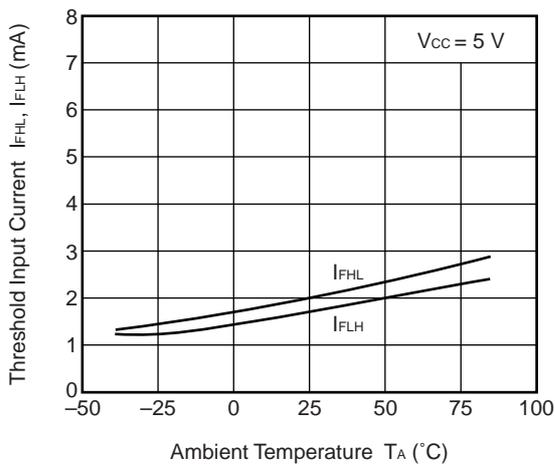
PROPAGATION DELAY TIME, PULSE WIDTH DISTORTION vs. FORWARD CURRENT



PROPAGATION DELAY TIME, PULSE WIDTH DISTORTION vs. AMBIENT TEMPERATURE



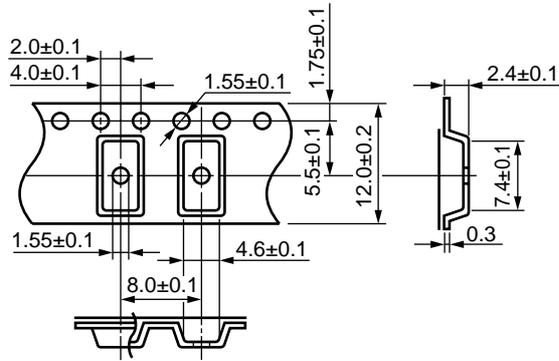
THRESHOLD INPUT CURRENT vs. AMBIENT TEMPERATURE



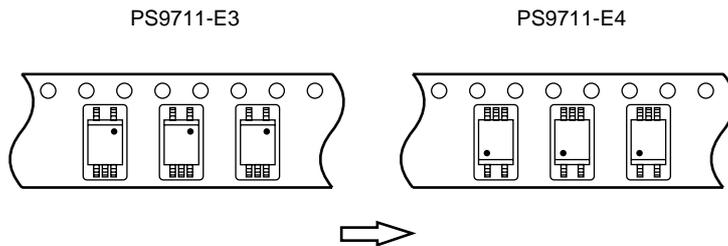
**Remark** The graphs indicate nominal characteristics.

★ TAPING SPECIFICATIONS (in millimeters)

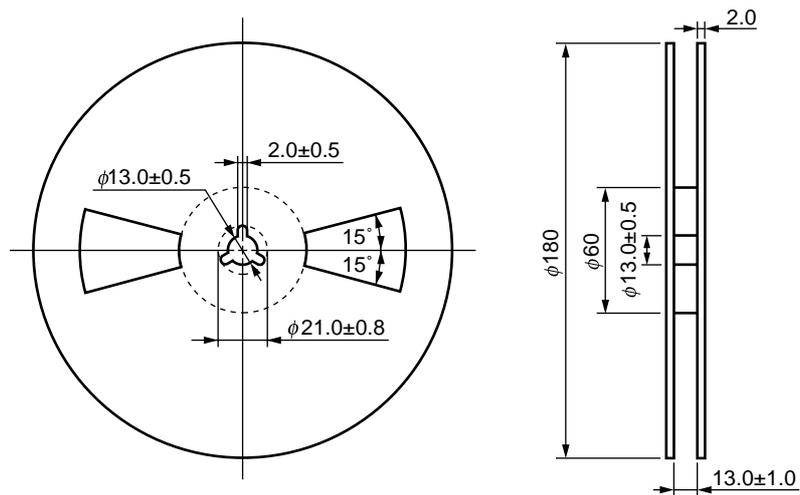
Outline and Dimensions (Tape)



Tape Direction

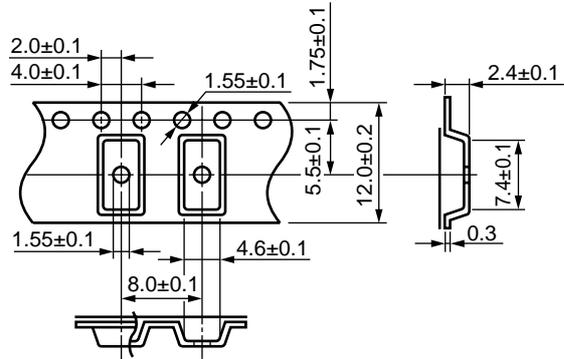


Outline and Dimensions (Tape)

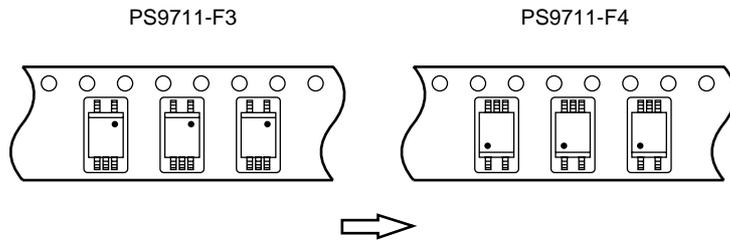


Packing: 900 pcs/reel

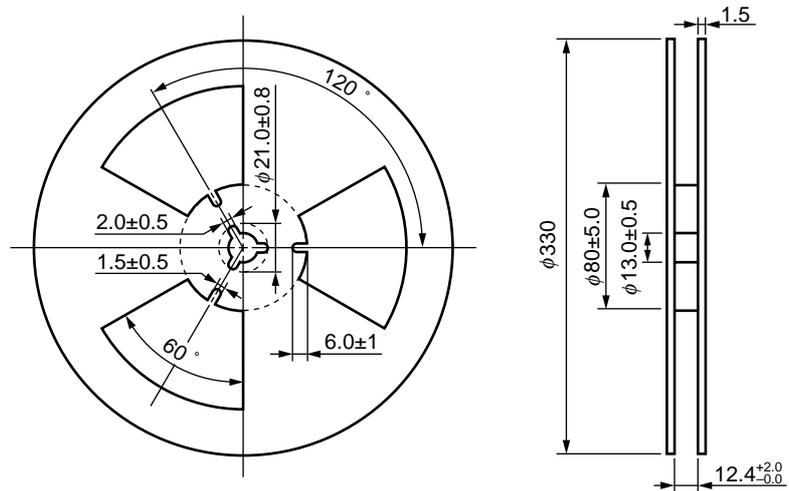
Outline and Dimensions (Tape)



Tape Direction



Outline and Dimensions (Reel)



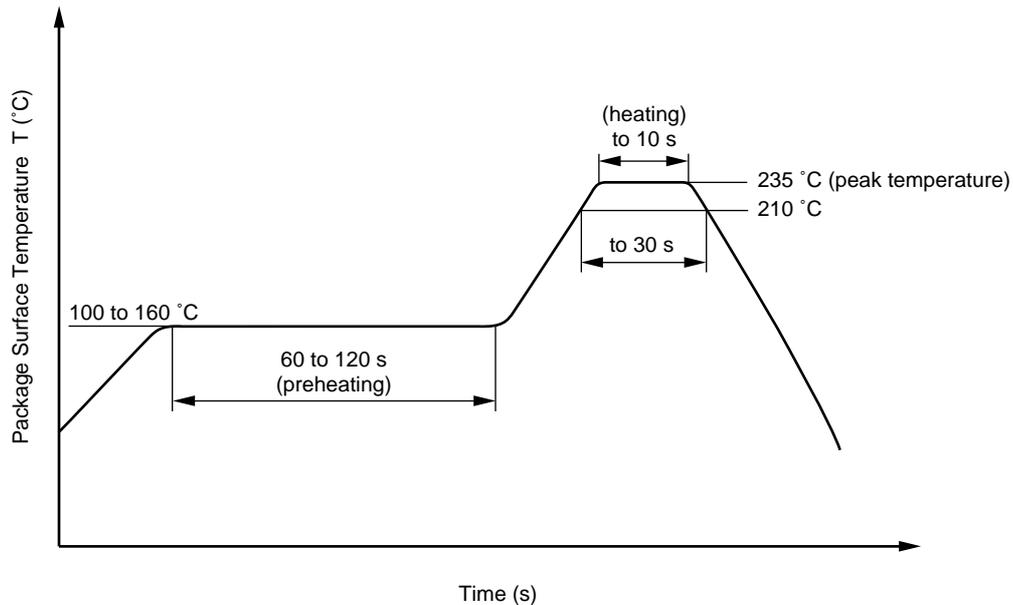
Packing: 3 500 pcs/reel

**RECOMMENDED SOLDERING CONDITIONS**

**(1) Infrared reflow soldering**

- ★ • Peak reflow temperature 235 °C or below (package surface temperature)
- Time of temperature higher than 210 °C 30 seconds or less
- Number of reflows Three
- Flux Rosin flux containing small amount of chlorine (The flux with a maximum chlorine content of 0.2 Wt % is recommended.)

★ Recommended Temperature Profile of Infrared Reflow



**(2) Dip soldering**

- Temperature 260 °C or below (molten solder temperature)
- Time 10 seconds or less
- Number of times One (Allowed to be dipped in solder including plastic mold portion.)
- Flux Rosin flux containing small amount of chlorine (The flux with a maximum chlorine content of 0.2 Wt % is recommended.)

**(3) Cautions**

- Fluxes  
Avoid removing the residual flux with freon-based and chlorine-based cleaning solvent.

[MEMO]

## CAUTION

**Within this device there exists GaAs (Gallium Arsenide) material which is a harmful substance if ingested. Please do not under any circumstances break the hermetic seal.**

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